

Search Notes

Application/Control No.

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Examiner

Noah Kamen

Applicant(s)/Patent under
Reexamination

BIEL, MICHAEL J.

Art Unit

3747

SEARCHED

Class	Subclass	Date	Examiner
search	updated	8/29/2005	NK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR